

## Product Summary

Device	$V_{(BR)DSS}$	$R_{DS(ON)}$ max	$I_D$ max $T_C = 25^\circ C$
Q1	30V	21m $\Omega$ @ $V_{GS} = 10V$	14A
		32m $\Omega$ @ $V_{GS} = 4.5V$	14A
Q2	-30V	39m $\Omega$ @ $V_{GS} = -10V$	-14A
		53m $\Omega$ @ $V_{GS} = -4.5V$	-14A

## Features and Benefits

- Low On-Resistance
- Low Input Capacitance
- Fast Switching Speed
- **Lead-Free Finish; RoHS Compliant (Notes 1 & 2)**
- **Halogen and Antimony Free. "Green" Device (Note 3)**
- **Qualified to AEC-Q101 standards for High Reliability**

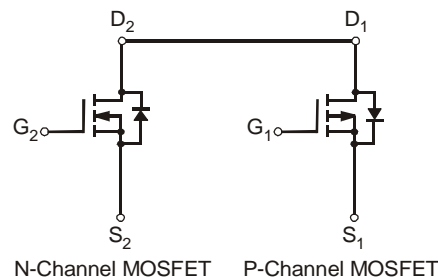
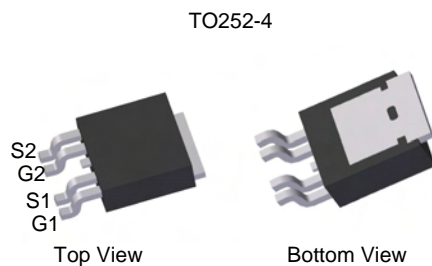
## Description and Applications

This MOSFET has been designed to minimize the on-state resistance ( $R_{DS(on)}$ ) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

- Motor control
- Power Management Functions
- DC-DC Converters
- Backlighting

## Mechanical Data

- Case: TO252-4
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections Indicator: See diagram
- Terminals: Finish – Matte Tin annealed over Copper leadframe. Solderable per MIL-STD-202, Method 208
- Weight: 0.027 grams (approximate)



## Ordering Information (Note 4)

Part Number	Case	Packaging
DMC3021LK4-13	TO252-4	2500/Tape & Reel

- Notes:
1. EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant. All applicable RoHS exemptions applied.
  2. See <http://www.diodes.com> for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
  3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
  4. For packaging details, go to our website at <http://www.diodes.com>

## Marking Information



= Manufacturer's Marking  
 C3021L = Product Type Marking Code  
 YYWW = Date Code Marking  
 YY = Year (ex: 11 = 2011)  
 WW = Week (01 - 53)

**Maximum Ratings N-CHANNEL – Q1** @ $T_A = 25^\circ\text{C}$  unless otherwise specified

Characteristic			Symbol	Value	Units
Drain-Source Voltage			$V_{DSS}$	30	V
Gate-Source Voltage			$V_{GSS}$	$\pm 20$	V
Continuous Drain Current (Note 5) $V_{GS} = 10\text{V}$	Steady State	$T_A = 25^\circ\text{C}$	$I_D$	9.4	A
		$T_A = 70^\circ\text{C}$		7.5	
Continuous Drain Current (Note 6 & 7) $V_{GS} = 10\text{V}$	Steady State	$T_C = 25^\circ\text{C}$	$I_D$	14	A
		$T_C = 70^\circ\text{C}$		14	
Pulsed Drain Current (Note 8)			$I_{DM}$	70	A

**Maximum Ratings P-CHANNEL – Q2** @ $T_A = 25^\circ\text{C}$  unless otherwise specified

Characteristic			Symbol	Value	Units
Drain-Source Voltage			$V_{DSS}$	-30	V
Gate-Source Voltage			$V_{GSS}$	$\pm 20$	V
Continuous Drain Current (Note 5) $V_{GS} = -10\text{V}$	Steady State	$T_A = 25^\circ\text{C}$	$I_D$	-6.8	A
		$T_A = 70^\circ\text{C}$		-5.3	
Continuous Drain Current (Note 6 & 7) $V_{GS} = -10\text{V}$	Steady State	$T_C = 25^\circ\text{C}$	$I_D$	-14	A
		$T_C = 70^\circ\text{C}$		-14	
Pulsed Drain Current (Note 8)			$I_{DM}$	-50	A

**Thermal Characteristics** @ $T_A = 25^\circ\text{C}$  unless otherwise specified

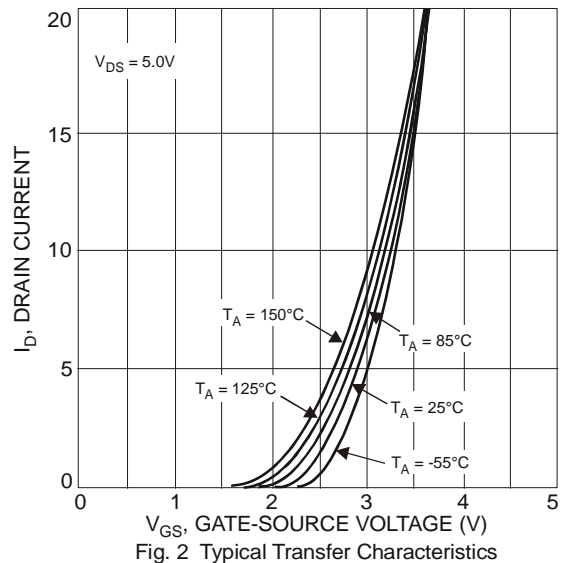
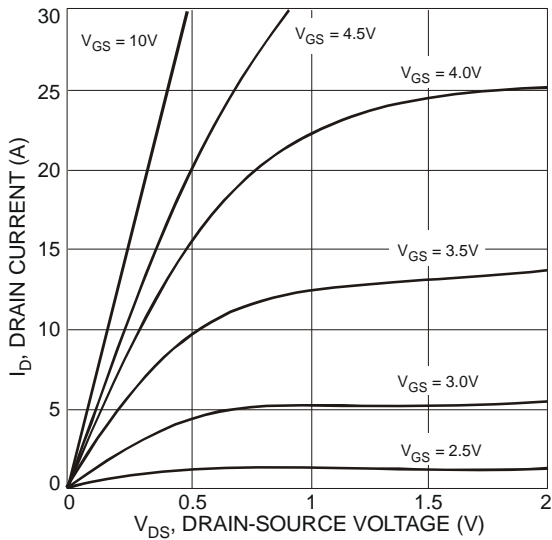
Characteristic		Symbol	Value	Units
Total Power Dissipation (Note 5)	$T_A = 25^\circ\text{C}$	$P_D$	2.7	W
	$T_A = 70^\circ\text{C}$		1.7	
Total Power Dissipation (Note 6)	$T_C = 25^\circ\text{C}$		22	
	$T_C = 70^\circ\text{C}$		14	
Thermal Resistance, Junction to Ambient (Note 5)	Steady state	$R_{\theta JA}$	46	$^\circ\text{C/W}$
Thermal Resistance, Junction to Case (Note 6)	Steady state	$R_{\theta JC}$	5.5	
Operating and Storage Temperature Range		$T_J, T_{STG}$	-55 to +150	$^\circ\text{C}$

- Notes:
5. Device mounted on FR-4 substrate PC board, 2oz copper, on 1inch square copper plate.
  6. Device mounted on infinite heatsink,  $T_C$  is measured on the bottom of package
  7. The maximum current rating is limited by bond-wires
  8. Device mounted on minimum recommended pad layout test board, 10 $\mu\text{s}$  pulse duty cycle = 1%.

**Electrical Characteristics N-CHANNEL – Q1** @ $T_A = 25^\circ\text{C}$  unless otherwise specified

Characteristic	Symbol	Min	Typ	Max	Unit	Test Condition
<b>OFF CHARACTERISTICS (Note 9)</b>						
Drain-Source Breakdown Voltage	$BV_{DSS}$	30	-	-	V	$V_{GS} = 0V, I_D = 250\mu A$
Zero Gate Voltage Drain Current @ $T_c = 25^\circ\text{C}$	$I_{DSS}$	-	-	1.0	$\mu A$	$V_{DS} = 30V, V_{GS} = 0V$
Gate-Source Leakage	$I_{GSS}$	-	-	$\pm 100$	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$
<b>ON CHARACTERISTICS (Note 9)</b>						
Gate Threshold Voltage	$V_{GS(th)}$	1	1.5	2.1	V	$V_{DS} = V_{GS}, I_D = 250\mu A$
Static Drain-Source On-Resistance	$R_{DS(on)}$	-	14	21	m $\Omega$	$V_{GS} = 10V, I_D = 7A$
		-	18	32		$V_{GS} = 4.5V, I_D = 5.6A$
Forward Transfer Admittance	$ Y_{fs} $	-	8.5	-	S	$V_{DS} = 5V, I_D = 7A$
Diode Forward Voltage	$V_{SD}$	-	0.7	1.0	V	$V_{GS} = 0V, I_S = 1A$
<b>DYNAMIC CHARACTERISTICS (Note 10)</b>						
Input Capacitance	$C_{iss}$	-	751	-	pF	$V_{DS} = 10V, V_{GS} = 0V,$ $f = 1.0\text{MHz}$
Output Capacitance	$C_{oss}$	-	121	-	pF	
Reverse Transfer Capacitance	$C_{rss}$	-	110	-	pF	$V_{DS} = 10V, V_{GS} = 0V, f = 1.0\text{MHz}$
Gate Resistance	$R_g$	-	1.5	-	$\Omega$	
Total Gate Charge (4.5V)	$Q_g$	-	9	-	nC	$V_{GS} = 10V, V_{DS} = 15V,$ $I_D = 6A$
Total Gate Charge (10V)	$Q_g$	-	17.4	-	nC	
Gate-Source Charge	$Q_{gs}$	-	2.2	-	nC	
Gate-Drain Charge	$Q_{gd}$	-	3	-	nC	
Turn-On Delay Time	$t_{D(on)}$	-	2.5	-	ns	$V_{DD} = 15V, V_{GS} = 10V,$ $R_G = 6\Omega, R_L = 1.8\Omega, I_D = 6.7A$
Turn-On Rise Time	$t_r$	-	6.6	-	ns	
Turn-Off Delay Time	$t_{D(off)}$	-	19.0	-	ns	
Turn-Off Fall Time	$t_f$	-	6.3	-	ns	

Notes: 9. Short duration pulse test used to minimize self-heating effect  
 10. Guaranteed by design. Not subject to product testing



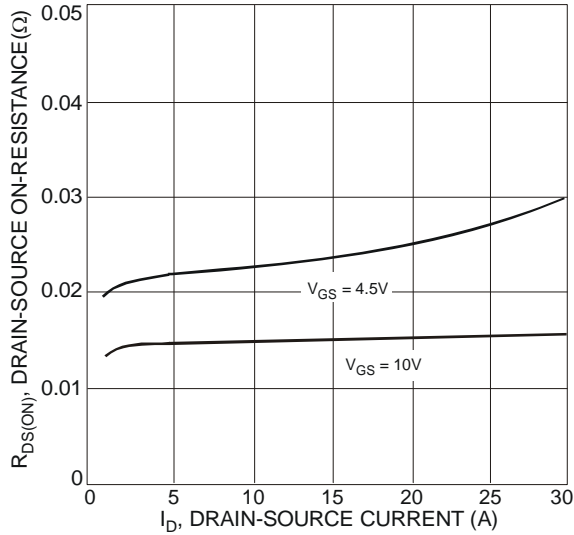


Fig. 3 Typical On-Resistance vs. Drain Current and Gate Voltage

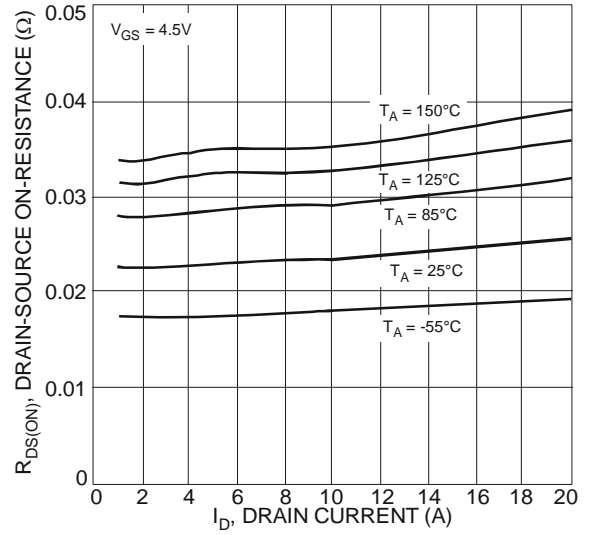


Fig. 4 Typical On-Resistance vs. Drain Current and Temperature

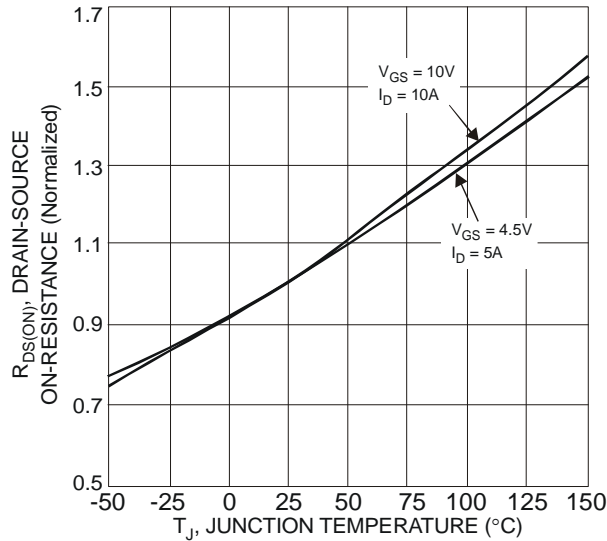


Fig. 5 On-Resistance Variation with Temperature

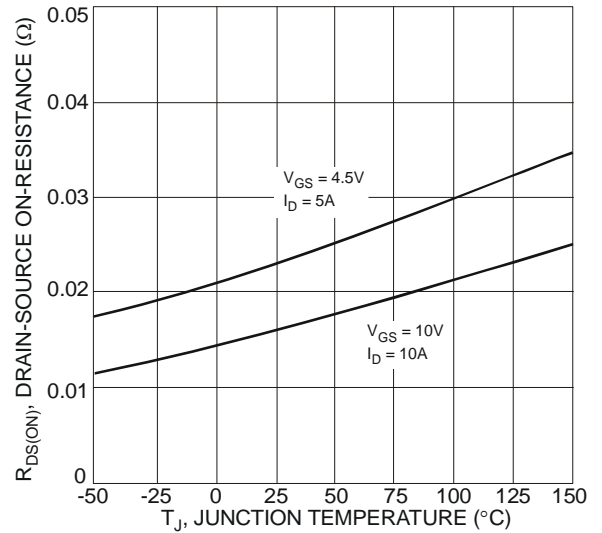


Fig. 6 On-Resistance Variation with Temperature

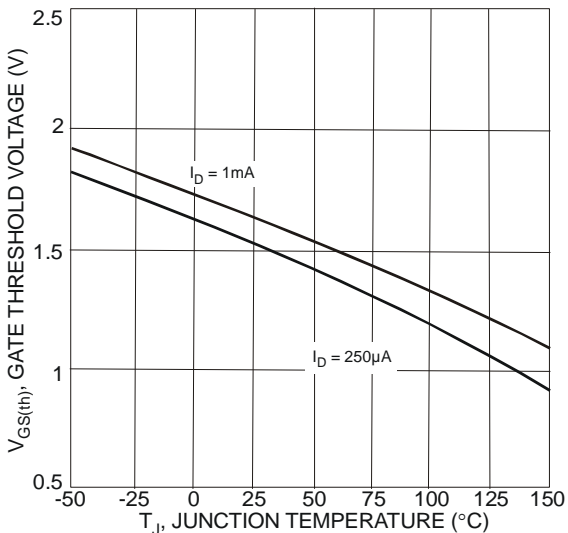


Fig. 7 On-Resistance Variation with Temperature

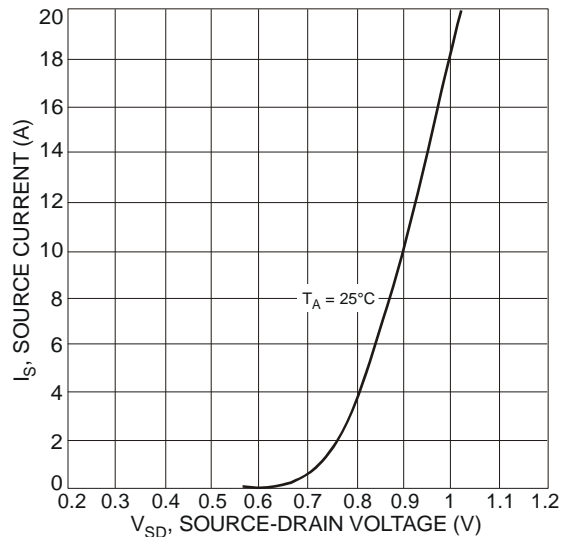


Fig. 8 Diode Forward Voltage vs. Current

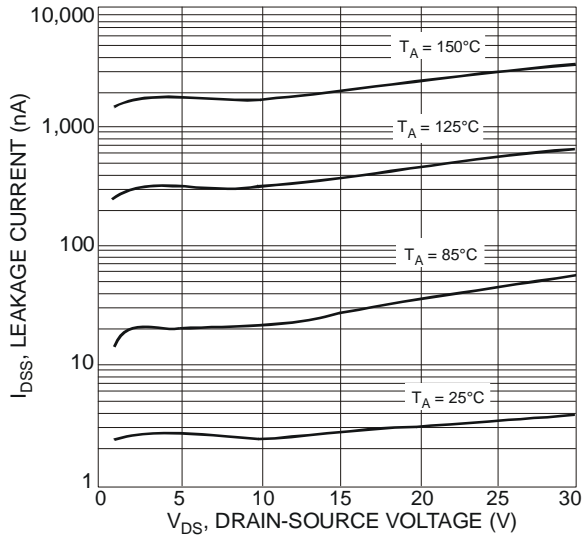


Fig. 9 Typical Drain-Source Leakage Current vs. Voltage

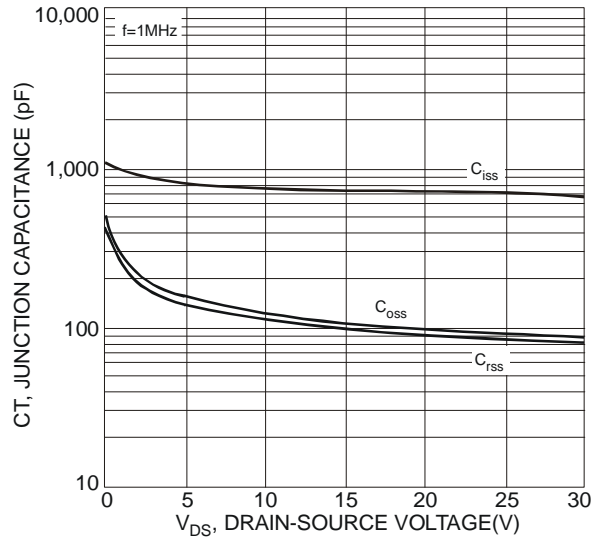


Fig. 10 Typical Junction Capacitance

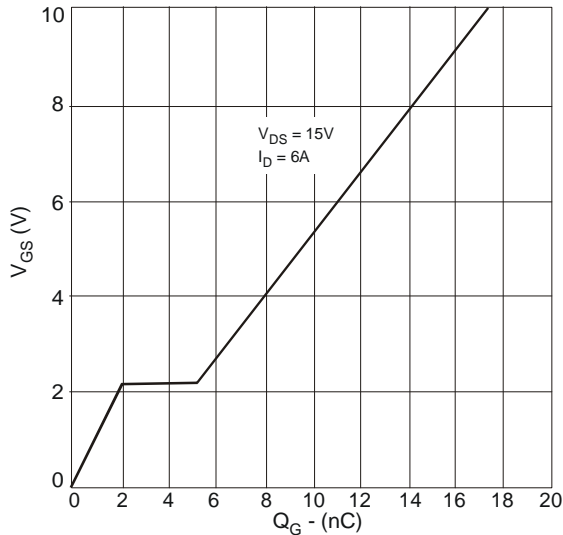


Fig. 11 Gate Charge Characteristics

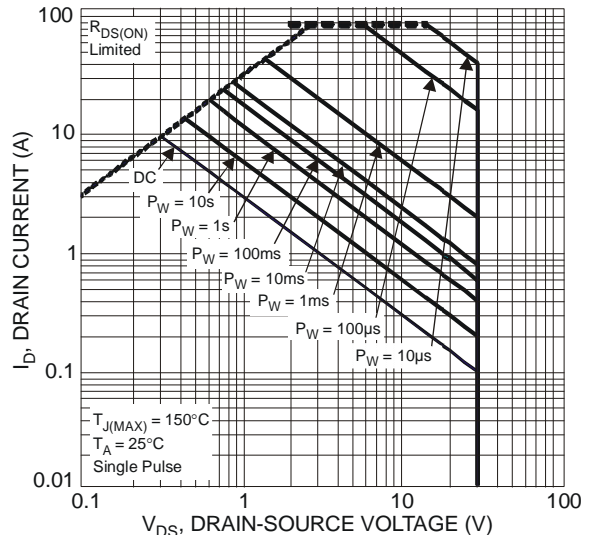
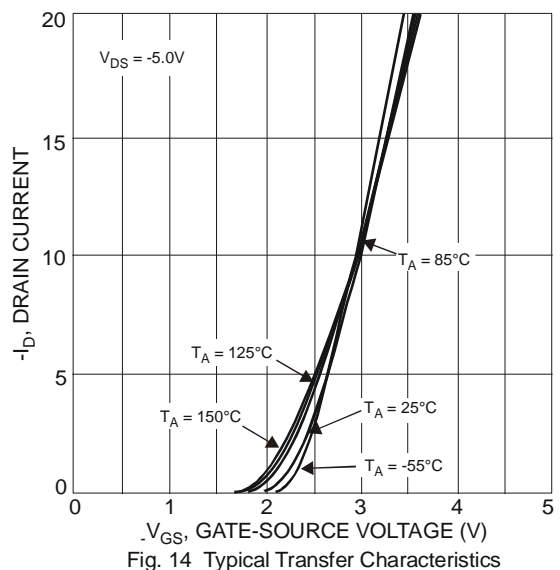
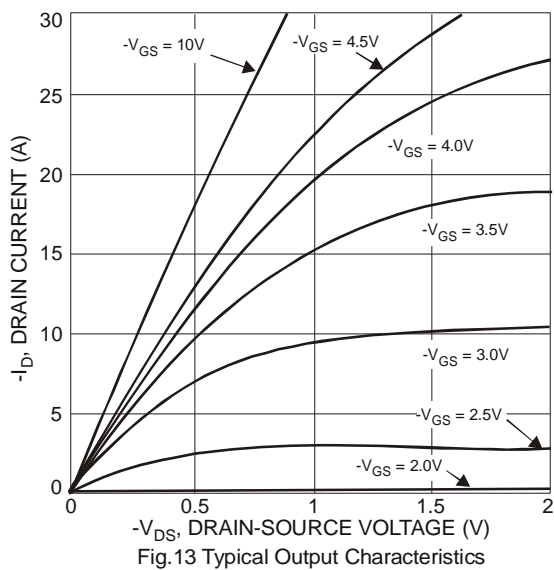


Fig. 12 SOA, Safe Operation Area

**Electrical Characteristics P-CHANNEL – Q2** @ $T_A = 25^\circ\text{C}$  unless otherwise specified

Characteristic	Symbol	Min	Typ	Max	Unit	Test Condition
<b>OFF CHARACTERISTICS (Note 9)</b>						
Drain-Source Breakdown Voltage	$BV_{DSS}$	-30	-	-	V	$V_{GS} = 0V, I_D = -250\mu A$
Zero Gate Voltage Drain Current @ $T_c = 25^\circ\text{C}$	$I_{DSS}$	-	-	-1	$\mu A$	$V_{DS} = -30V, V_{GS} = 0V$
Gate-Source Leakage	$I_{GSS}$	-	-	$\pm 100$	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$
<b>ON CHARACTERISTICS (Note 9)</b>						
Gate Threshold Voltage	$V_{GS(th)}$	-1	-1.7	-2.2	V	$V_{DS} = V_{GS}, I_D = -250\mu A$
Static Drain-Source On-Resistance	$R_{DS(on)}$	-	30	39	m $\Omega$	$V_{GS} = -10V, I_D = -4.3A$
		-	42	53		$V_{GS} = -4.5V, I_D = -3.7A$
Forward Transfer Admittance	$ Y_{fs} $	-	10	-	S	$V_{DS} = -5V, I_D = -4.3A$
Diode Forward Voltage	$V_{SD}$	-	-0.75	-1.0	V	$V_{GS} = 0V, I_S = -1A$
<b>DYNAMIC CHARACTERISTICS (Note 10)</b>						
Input Capacitance	$C_{iss}$	-	1039	-	pF	$V_{DS} = -10V, V_{GS} = 0V, f = 1.0\text{MHz}$
Output Capacitance	$C_{oss}$	-	144	-	pF	
Reverse Transfer Capacitance	$C_{rss}$	-	134	-	pF	
Gate Resistance	$R_g$	-	13	-	$\Omega$	$V_{DS} = 0V, V_{GS} = 0V, f = 1.0\text{MHz}$
Total Gate Charge (4.5V)	$Q_g$	-	10.1	-	nC	$V_{GS} = -10V, V_{DS} = -15V, I_D = -6A$
Total Gate Charge (10V)	$Q_g$	-	21.1	-	nC	
Gate-Source Charge	$Q_{gs}$	-	2.8	-	nC	
Gate-Drain Charge	$Q_{gd}$	-	3.2	-	nC	
Turn-On Delay Time	$t_{D(on)}$	-	10.1	-	ns	$V_{DS} = -15V, V_{GS} = -10V, R_G = 6\Omega, I_D = -1A$
Turn-On Rise Time	$t_r$	-	6.5	-	ns	
Turn-Off Delay Time	$t_{D(off)}$	-	50.1	-	ns	
Turn-Off Fall Time	$t_f$	-	22.2	-	ns	

Notes: 9. Short duration pulse test used to minimize self-heating effect  
 10. Guaranteed by design. Not subject to product testing.



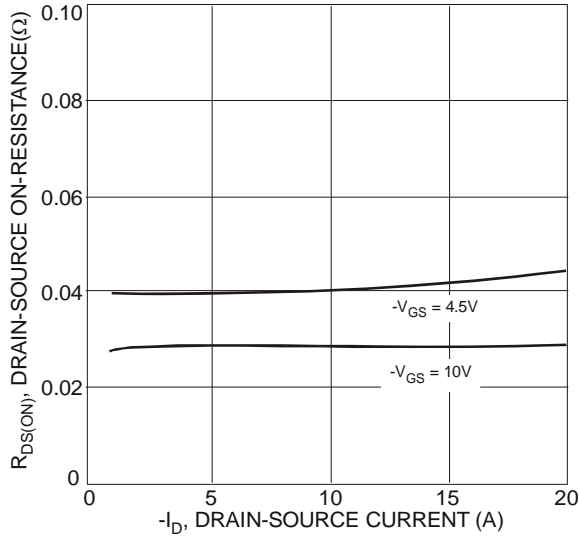


Fig. 15 Typical On-Resistance vs. Drain Current and Gate Voltage

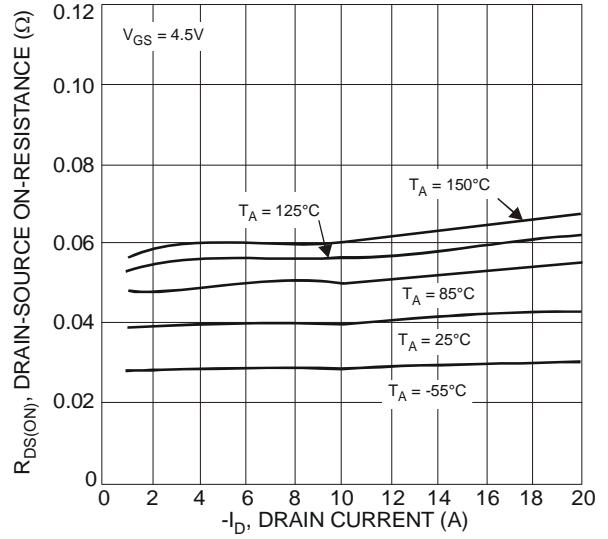


Fig. 16 Typical On-Resistance vs. Drain Current and Temperature

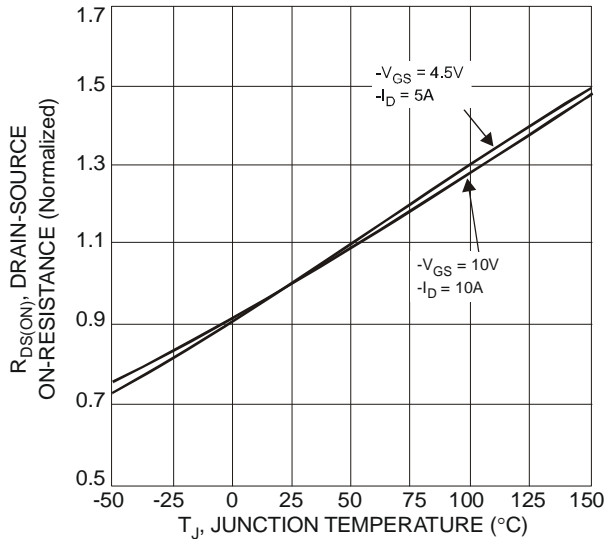


Fig. 17 On-Resistance Variation with Temperature

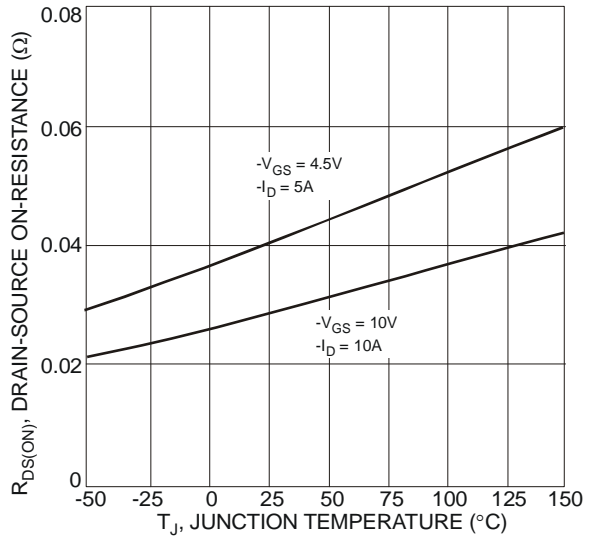


Fig. 18 On-Resistance Variation with Temperature

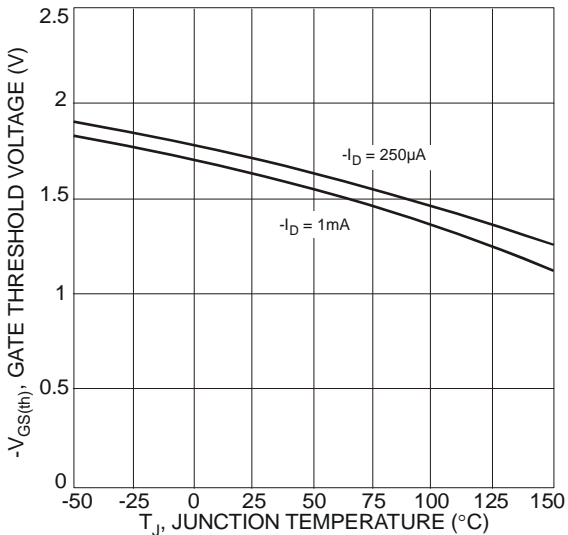


Fig. 19 On-Resistance Variation with Temperature

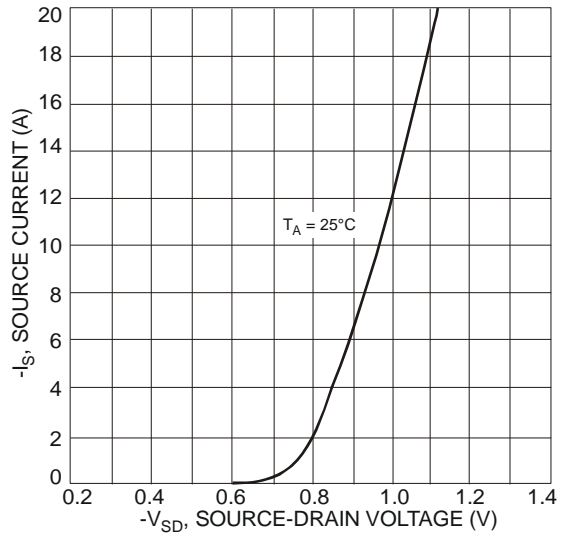


Fig. 20 Diode Forward Voltage vs. Current

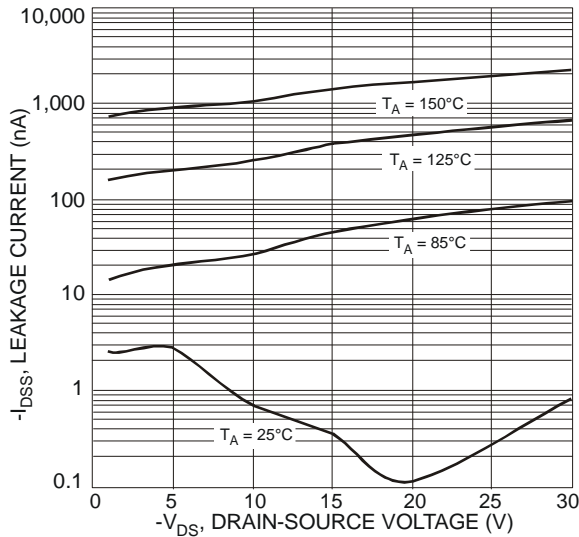


Fig. 21 Typical Drain-Source Leakage Current vs. Voltage

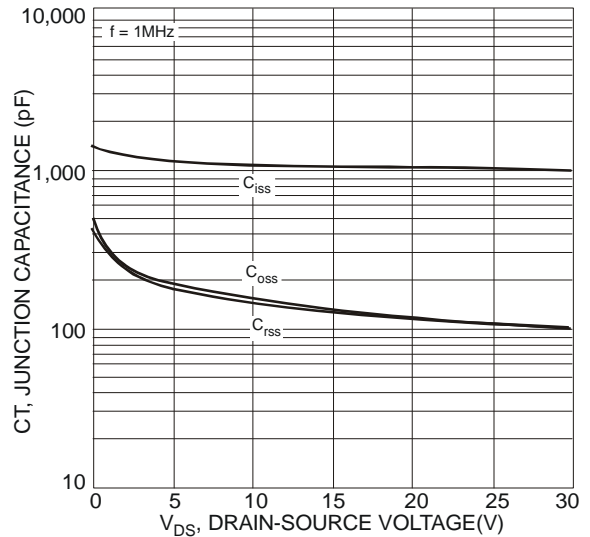


Fig. 22 Typical Junction Capacitance

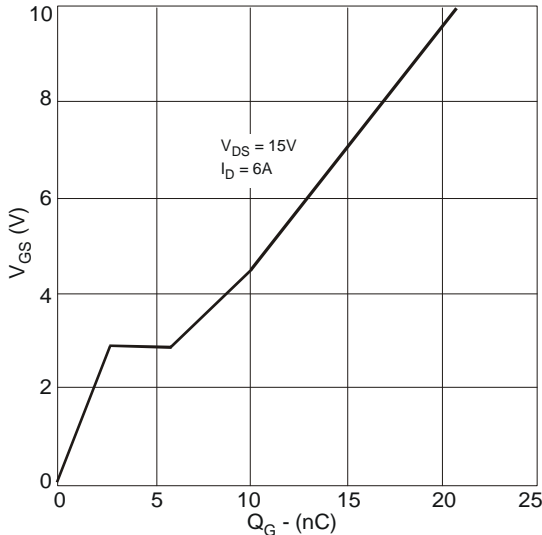


Fig. 23 Gate Charge Characteristics

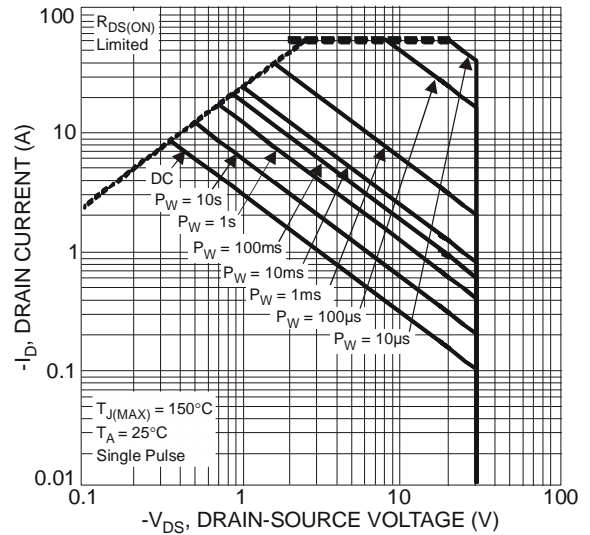


Fig. 24 SOA, Safe Operation Area

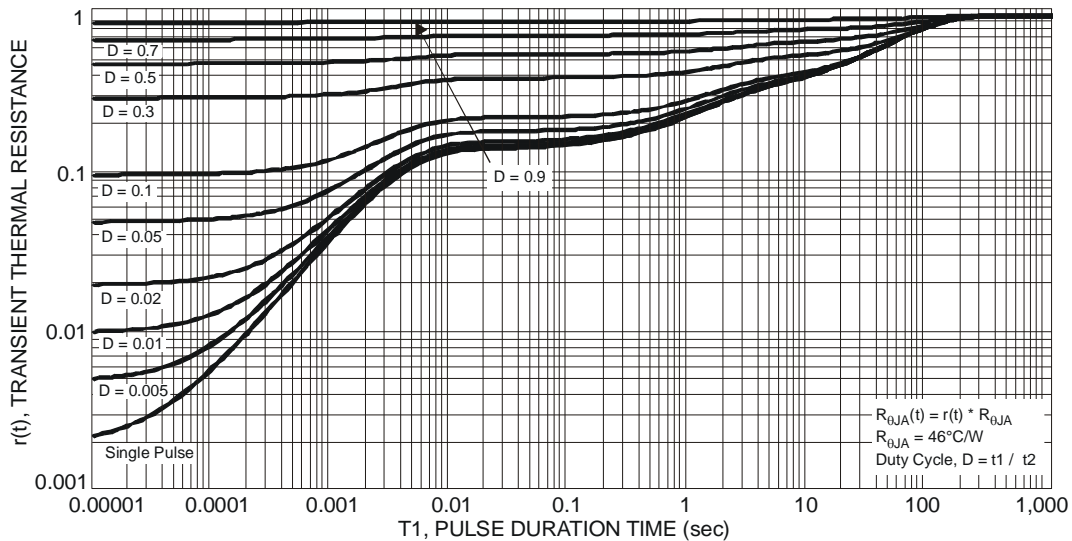
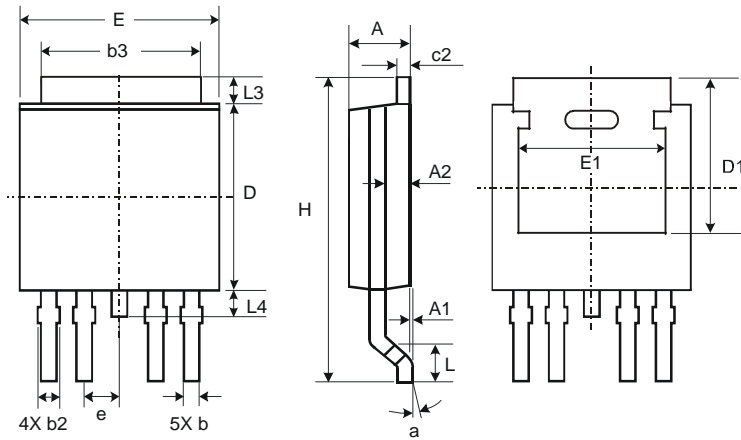


Fig. 25 Transient Thermal Resistance

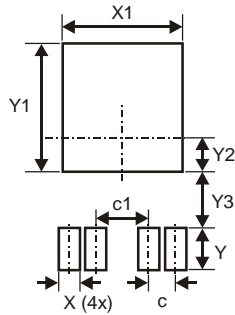


**Package Outline Dimensions**



TO252-4			
Dim	Min	Max	Typ
A	2.19	2.39	2.29
A1	0.00	0.13	0.08
A2	0.97	1.17	1.07
b	0.51	0.71	0.583
b2	0.61	0.79	0.70
b3	5.21	5.46	5.33
c2	0.45	0.58	0.531
D	6.00	6.20	6.10
D1	5.21	-	-
e	-	-	1.27
E	6.45	6.70	6.58
E1	4.32	-	-
H	9.40	10.41	9.91
L	1.40	1.78	1.59
L3	0.88	1.27	1.08
L4	0.64	1.02	0.83
a	0°	10°	-
<b>All Dimensions in mm</b>			

**Suggested Pad Layout**



Dimensions	Value (in mm)
c	1.27
c1	2.54
X	1.00
X1	5.73
Y	2.00
Y1	6.17
Y2	1.64
Y3	2.66

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- Поставка электронных компонентов под контролем ВП;
- Система менеджмента качества сертифицирована по Международному стандарту ISO 9001;
- При необходимости вся продукция военного и аэрокосмического назначения проходит испытания и сертификацию в лаборатории (по согласованию с заказчиком);
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«**JONHON**» (основан в 1970 г.)

Разъемы специального, военного и аэрокосмического назначения:

(Применяются в военной, авиационной, аэрокосмической, морской, железнодорожной, горно- и нефтедобывающей отраслях промышленности)

«**FORSTAR**» (основан в 1998 г.)

ВЧ соединители, коаксиальные кабели, кабельные сборки и микроволновые компоненты:

(Применяются в телекоммуникациях гражданского и специального назначения, в средствах связи, РЛС, а так же военной, авиационной и аэрокосмической отраслях промышленности).



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